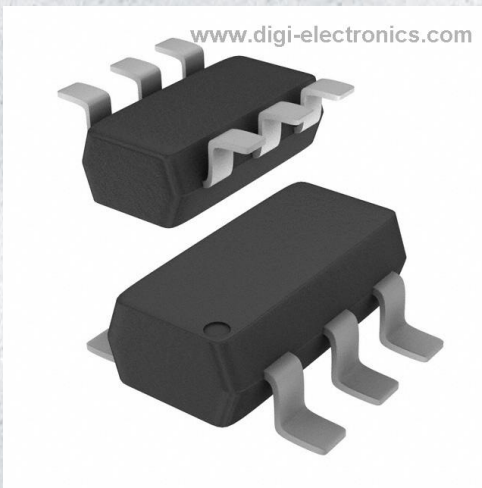


BSL806NL6327HTSA1 Datasheet



<https://www.DiGi-Electronics.com>

DiGi Electronics Part Number	BSL806NL6327HTSA1-DG
Manufacturer	Infineon Technologies
Manufacturer Product Number	BSL806NL6327HTSA1
Description	MOSFET 2N-CH 20V 2.3A TSOP6-6
Detailed Description	Mosfet Array 20V 2.3A 500mW Surface Mount PG-T SOP6-6



Tel: +00 852-30501935

RFQ Email: Info@DiGi-Electronics.com

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Purchase and inquiry

Manufacturer Product Number:

BSL806NL6327HTSA1

Series:

OptiMOS™

Technology:

MOSFET (Metal Oxide)

FET Feature:

Logic Level Gate

Current - Continuous Drain (Id) @ 25°C:

2.3A

Vgs(th) (Max) @ Id:

750mV @ 11µA

Input Capacitance (Ciss) (Max) @ Vds:

259pF @ 10V

Operating Temperature:

-55°C ~ 150°C (TJ)

Package / Case:

SOT-23-6 Thin, TSOT-23-6

Base Product Number:

BSL806

Manufacturer:

Infineon Technologies

Product Status:

Obsolete

Configuration:

2 N-Channel (Dual)

Drain to Source Voltage (Vdss):

20V

Rds On (Max) @ Id, Vgs:

57mOhm @ 2.3A, 2.5V

Gate Charge (Qg) (Max) @ Vgs:

1.7nC @ 2.5V

Power - Max:

500mW

Mounting Type:

Surface Mount

Supplier Device Package:

PG-TSOP6-6

Environmental & Export classification

Moisture Sensitivity Level (MSL):

1 (Unlimited)

ECCN:

EAR99

REACH Status:

REACH Unaffected

HTSUS:

8541.21.0095



BSL806N

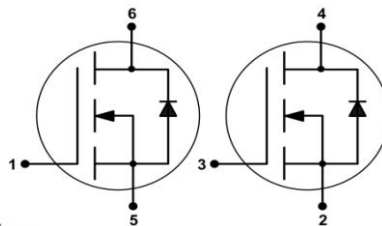
OptiMOS™ 2 Small-Signal-Transistor

Features

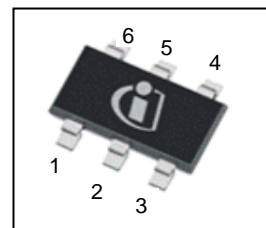
- Dual N-channel
- Enhancement mode
- Ultra Logic level (1.8V rated)
- Avalanche rated
- Qualified according to AEC Q101
- 100% lead-free; RoHS compliant
- Halogen free according to IEC61249-2-21



Halogen-Free



PG-TSOP6



Product Summary

V_{DS}	20	V
$R_{DS(on),max}$	$V_{GS}=2.5\text{ V}$	57
	$V_{GS}=1.8\text{ V}$	82
I_D	2.3	A

Type	Package	Tape and Reel Information	Marking	Lead Free	Packing
BSL806N	PG-TSOP6	H6327: 3000 pcs/ reel	sPO	Yes	Non dry

Maximum ratings, at $T_j=25\text{ °C}$, unless otherwise specified

Parameter ⁽¹⁾	Symbol	Conditions	Value	Unit
Continuous drain current	I_D	$T_A=25\text{ °C}$	2.3	A
		$T_A=70\text{ °C}$	1.9	
Pulsed drain current	$I_{D,pulse}$	$T_A=25\text{ °C}$	9.3	
Avalanche energy, single pulse	E_{AS}	$I_D=2.3\text{ A}$, $R_{GS}=25\ \Omega$	10.8	mJ
Reverse diode dv/dt	dv/dt	$I_D=2.3\text{ A}$, $V_{DS}=16\text{ V}$, $di/dt=200\text{ A}/\mu\text{s}$, $T_{j,max}=150\text{ °C}$	6	kV/ μs
Gate source voltage	V_{GS}		± 8	V
Power dissipation ¹⁾	P_{tot}	$T_A=25\text{ °C}$	0.5	W
Operating and storage temperature	T_j , T_{stg}		-55 ... 150	$^{\circ}\text{C}$
ESD Class		JESD22-A114 -HBM	0 (<250V)	
Soldering Temperature			260 $^{\circ}\text{C}$	
IEC climatic category; DIN IEC 68-1			55/150/56	

¹⁾ Remark: one of both transistors active



BSL806N

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	

Thermal characteristics

Thermal resistance, junction - ambient	R_{thJA}	minimal footprint ²⁾	-	-	250	K/W
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Electrical characteristics, at $T_j=25\text{ °C}$, unless otherwise specified

Static characteristics

Drain-source breakdown voltage	$V_{(BR)DSS}$	$V_{GS}=0\text{ V}, I_D=250\text{ }\mu\text{A}$	20	-	-	V
Gate threshold voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}, I_D=11\text{ }\mu\text{A}$	0.3	0.55	0.75	
Drain-source leakage current	I_{DSS}	$V_{DS}=20\text{ V}, V_{GS}=0\text{ V}, T_j=25\text{ °C}$	-	-	1	μA
		$V_{DS}=20\text{ V}, V_{GS}=0\text{ V}, T_j=150\text{ °C}$	-	-	100	
Gate-source leakage current	I_{GSS}	$V_{GS}=8\text{ V}, V_{DS}=0\text{ V}$	-	-	100	nA
Drain-source on-state resistance	$R_{DS(on)}$	$V_{GS}=1.8\text{ V}, I_D=1.3\text{ A}$	-	55	82	$\text{m}\Omega$
		$V_{GS}=2.5\text{ V}, I_D=2.3\text{ A}$	-	40	57	
Transconductance	g_{fs}	$ V_{DS} >2 I_D R_{DS(on)max}, I_D=1.9\text{ A}$		9	-	S

²⁾ Performed on 40mm² FR4 PCB. The traces are 1mm wide, 70 μm thick and 20mm long; they are present on both sides of the PCB.



BSL806N

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	

Dynamic characteristics

Input capacitance	C_{iss}	$V_{GS}=0\text{ V}, V_{DS}=10\text{ V},$ $f=1\text{ MHz}$	-	370	259	pF
Output capacitance	C_{oss}		-	118	169	
Reverse transfer capacitance	C_{rss}		-	20	28.6	
Turn-on delay time	$t_{d(on)}$	$V_{DD}=10\text{ V}, V_{GS}=2.5\text{ V},$ $I_D=2.3\text{ A}, R_{G,ext}=6\ \Omega$	-	7.5	-	ns
Rise time	t_r		-	9.9	-	
Turn-off delay time	$t_{d(off)}$		-	12	-	
Fall time	t_f		-	3.7	-	

Gate Charge Characteristics

Gate to source charge	Q_{gs}	$V_{DD}=10\text{ V}, I_D=2.3\text{ A},$ $V_{GS}=0\text{ to }2.5\text{ V}$	-	0.55	-	nC
Gate to drain charge	Q_{gd}		-	0.58	-	
Gate charge total	Q_g		-	1.7	-	
Gate plateau voltage	$V_{plateau}$		-	1.5	-	V

Reverse Diode

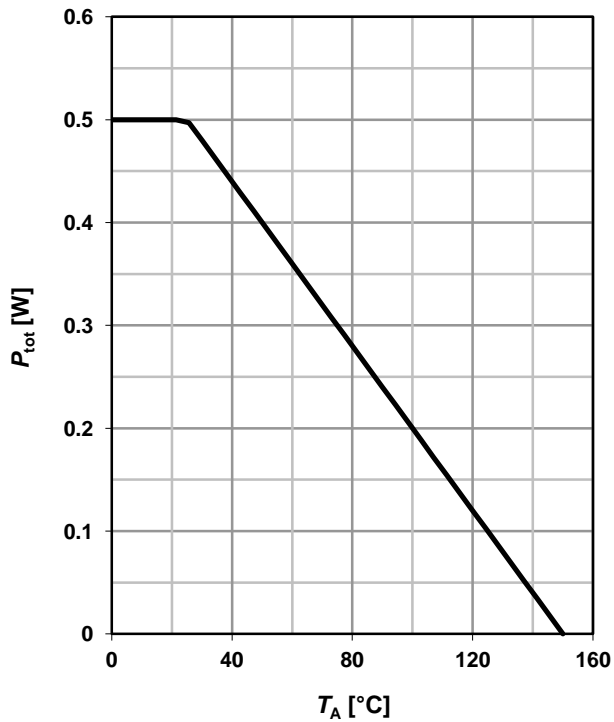
Diode continuous forward current	I_S	$T_A=25\text{ }^\circ\text{C}$	-	-	0.5	A
Diode pulse current	$I_{S,pulse}$		-	-	9.3	
Diode forward voltage	V_{SD}	$V_{GS}=0\text{ V}, I_F=2.3\text{ A},$ $T_j=25\text{ }^\circ\text{C}$	-	0.82	1.1	V
Reverse recovery time	t_{rr}	$V_R=10\text{ V}, I_F=2.3\text{ A},$ $di_F/dt=100\text{ A}/\mu\text{s}$	-	11	-	ns
Reverse recovery charge	Q_{rr}		-	3.3	-	nC



BSL806N

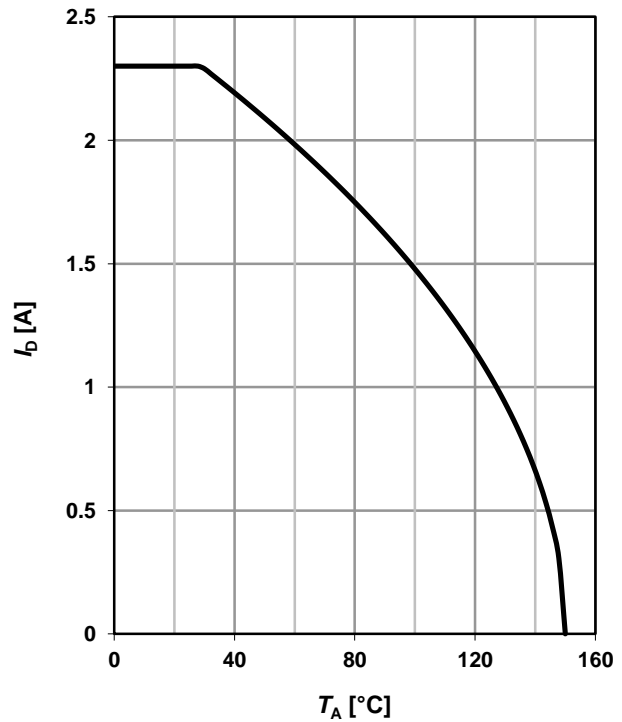
1 Power dissipation

$$P_{\text{tot}} = f(T_A)$$



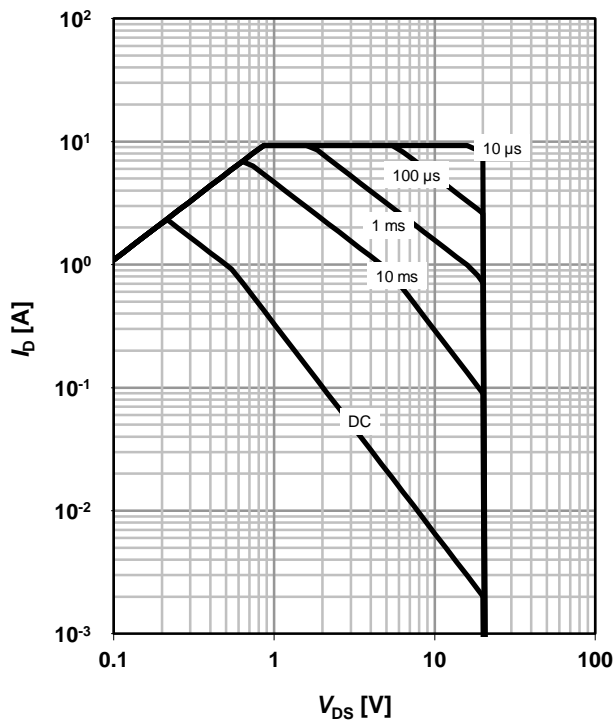
2 Drain current

$$I_D = f(T_A); V_{\text{GS}} \geq 2.5 \text{ V}$$



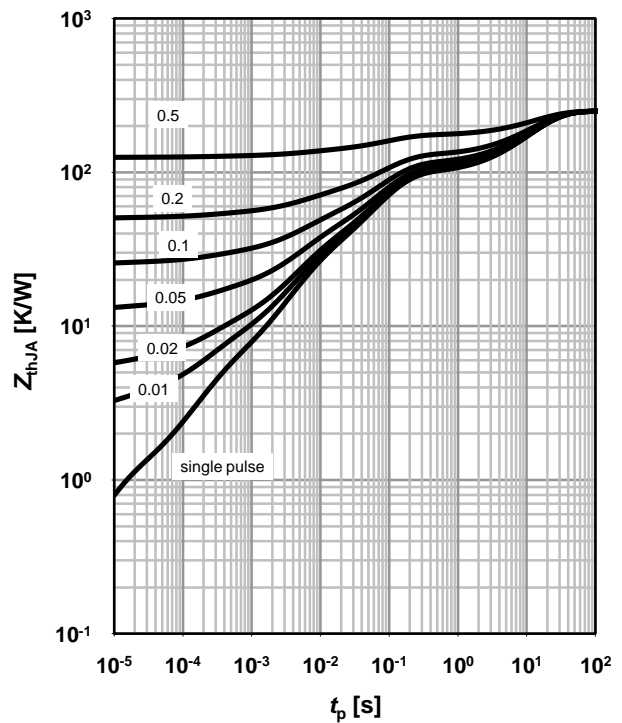
3 Safe operating area

$$I_D = f(V_{\text{DS}}); T_A = 25 \text{ °C}; D = 0$$

parameter: t_p 

4 Max. transient thermal impedance

$$Z_{\text{thJA}} = f(t_p)$$

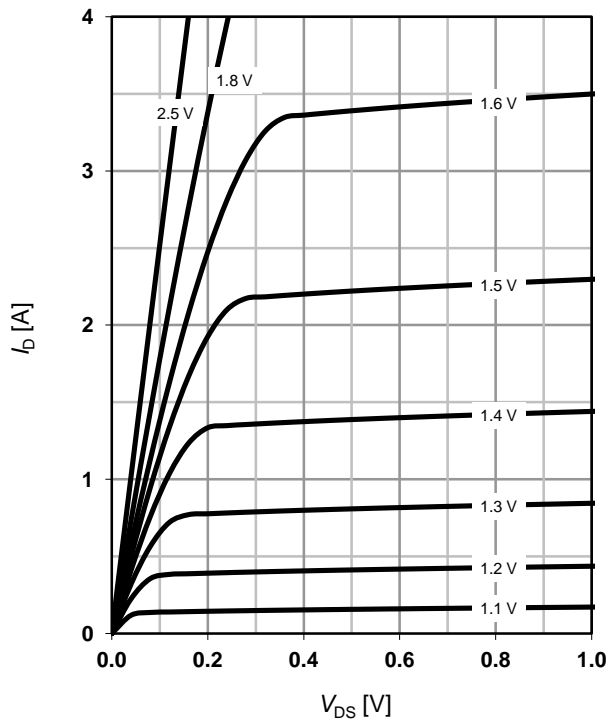
parameter: $D = t_p/T$ 



5 Typ. output characteristics

$$I_D = f(V_{DS}); T_j = 25^\circ\text{C}$$

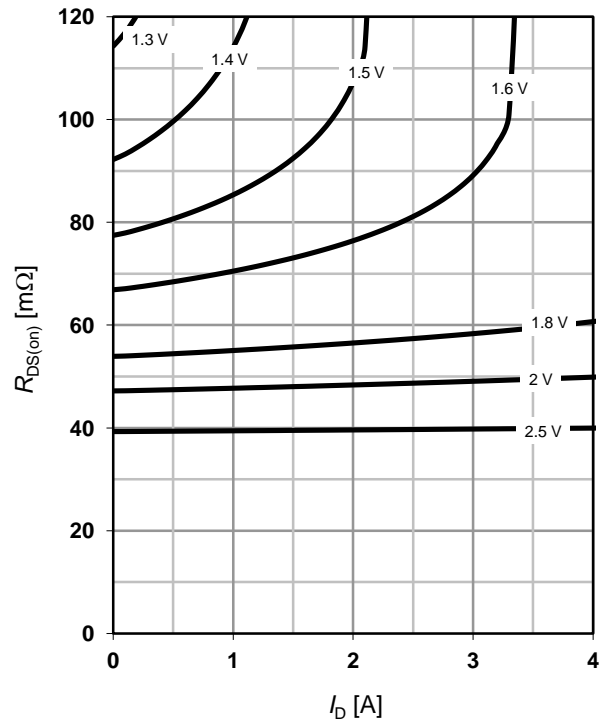
parameter: V_{GS}



6 Typ. drain-source on resistance

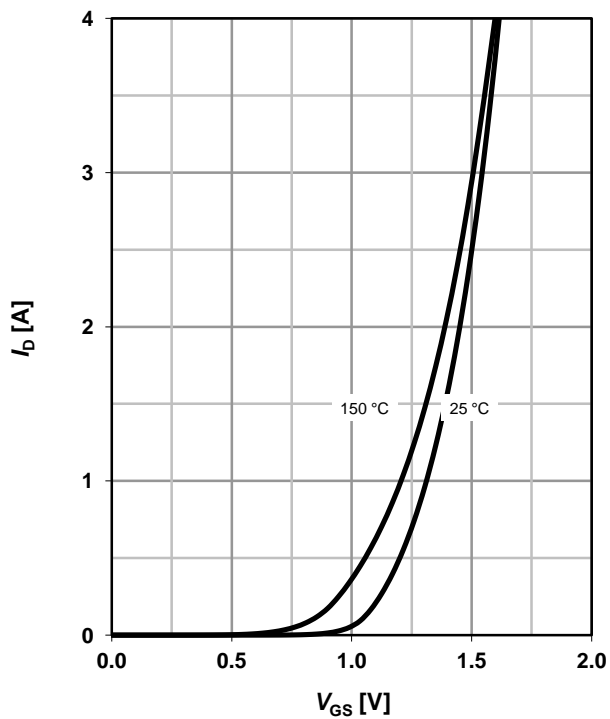
$$R_{DS(on)} = f(I_D); T_j = 25^\circ\text{C}$$

parameter: V_{GS}



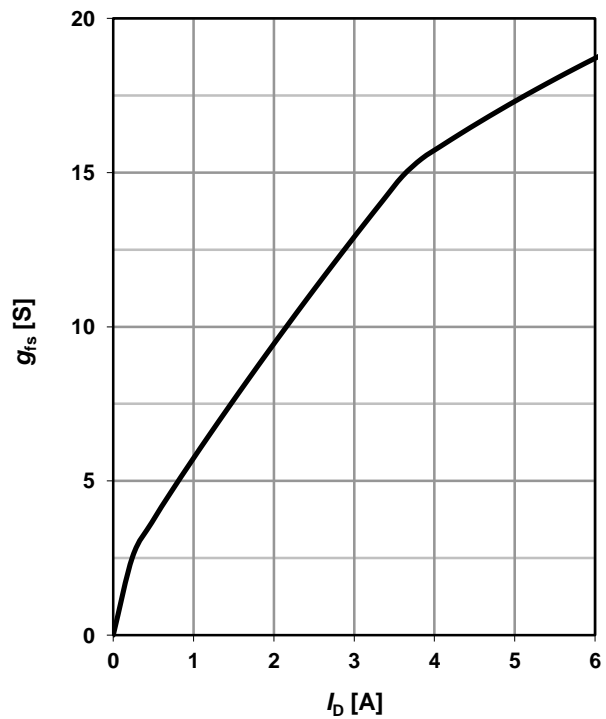
7 Typ. transfer characteristics

$$I_D = f(V_{GS}); |V_{DS}| > 2|I_D|R_{DS(on)max}$$



8 Typ. forward transconductance

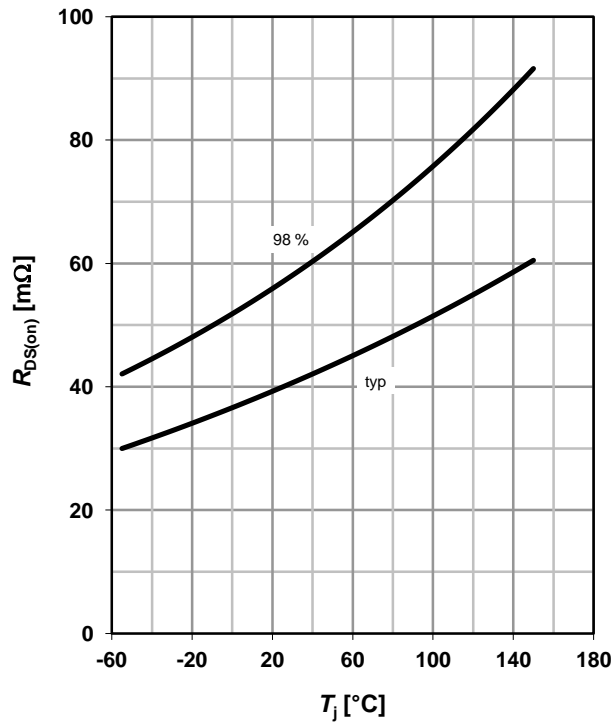
$$g_{fs} = f(I_D); T_j = 25^\circ\text{C}$$





9 Drain-source on-state resistance

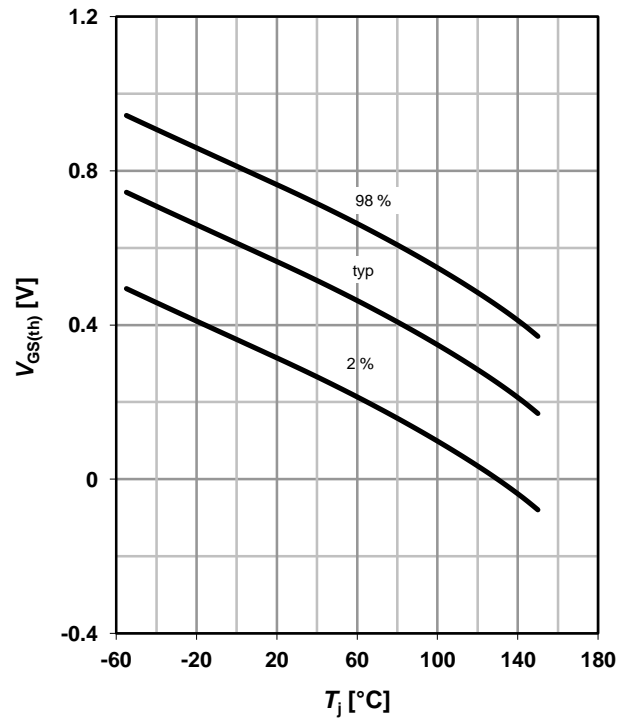
$$R_{DS(on)}=f(T_j); I_D=2.3 \text{ A}; V_{GS}=2.5 \text{ V}$$



10 Typ. gate threshold voltage

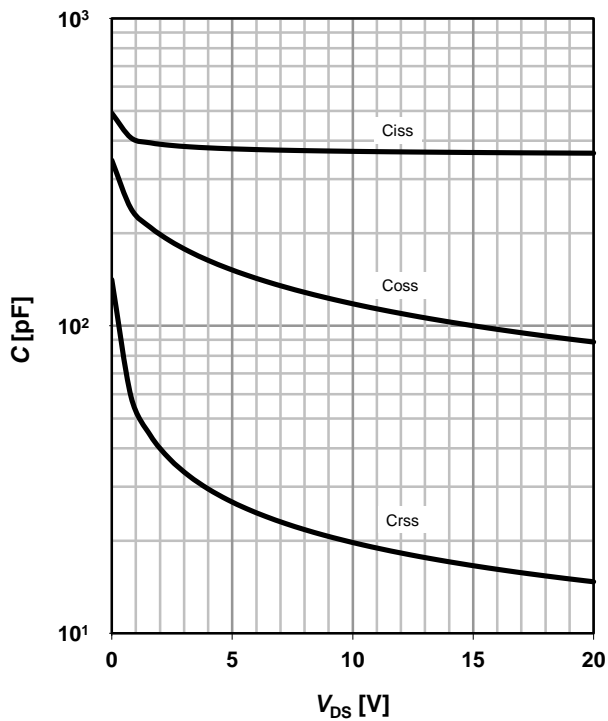
$$V_{GS(th)}=f(T_j); V_{DS}=V_{GS}; I_D=11 \mu\text{A}$$

parameter: I_D



11 Typ. capacitances

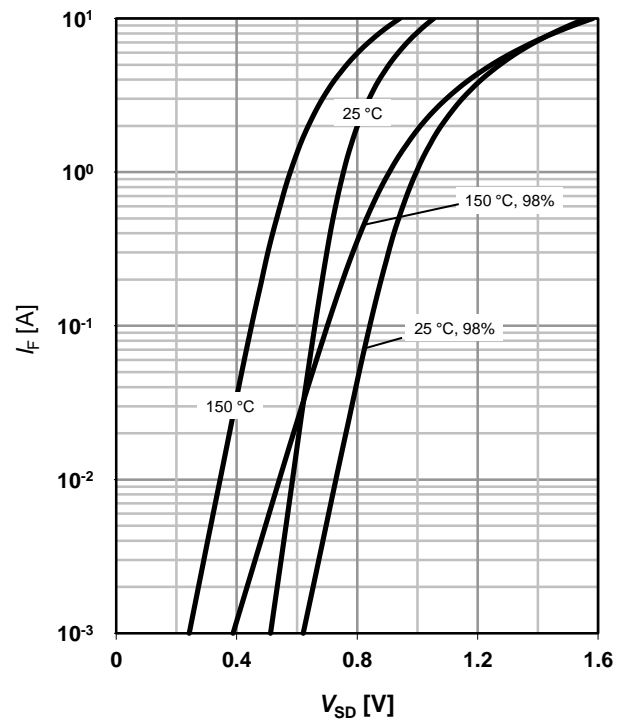
$$C=f(V_{DS}); V_{GS}=0 \text{ V}; f=1 \text{ MHz}; T_j=25^\circ\text{C}$$



12 Forward characteristics of reverse diode

$$I_F=f(V_{SD})$$

parameter: T_j



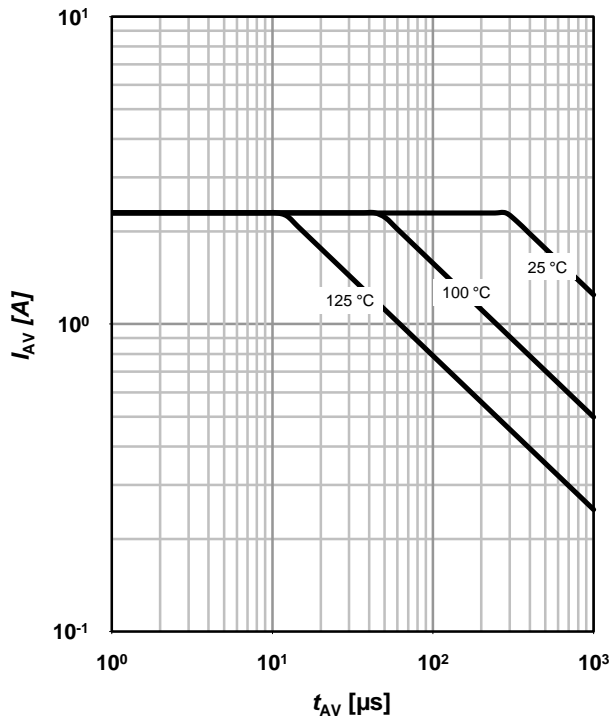


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13 Avalanche characteristics

$$I_{AS}=f(t_{AV}); R_{GS}=25\ \Omega$$

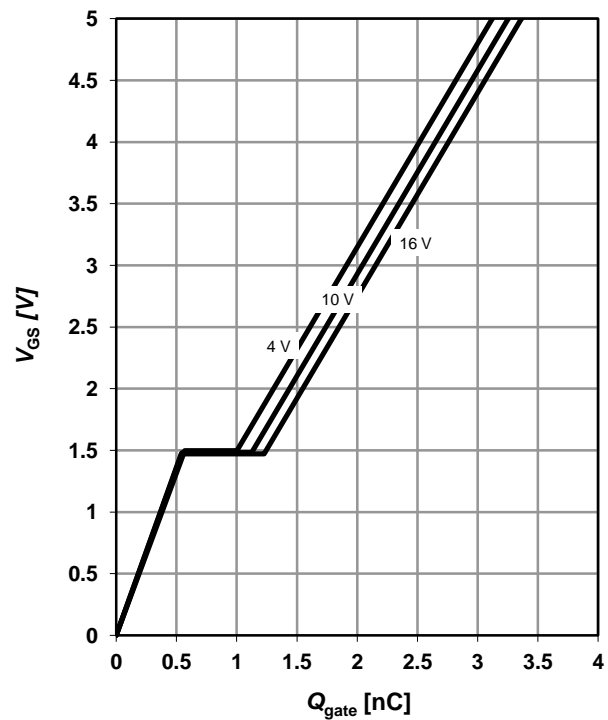
parameter: $T_{j(\text{start})}$



14 Typ. gate charge

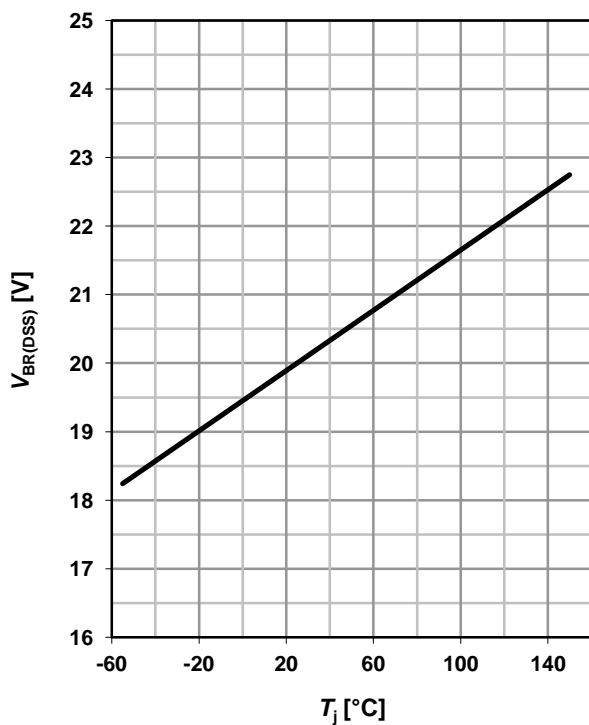
$$V_{GS}=f(Q_{\text{gate}}); I_D=2.3\ \text{A pulsed}$$

parameter: V_{DD}

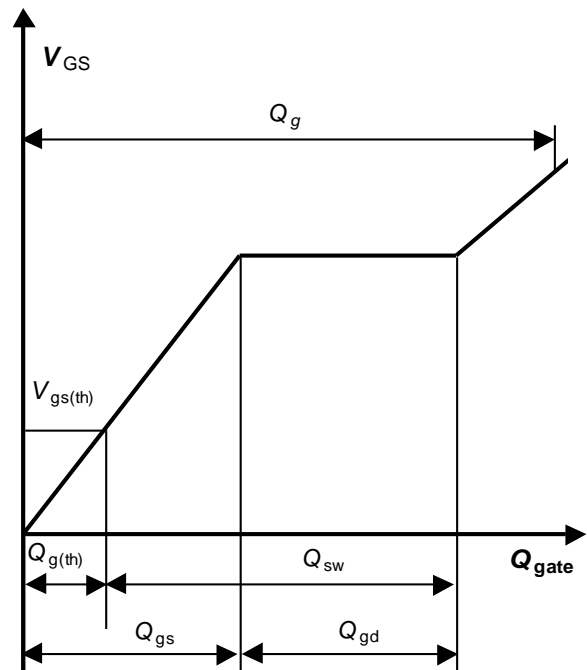


15 Drain-source breakdown voltage

$$V_{BR(DSS)}=f(T_j); I_D=250\ \mu\text{A}$$



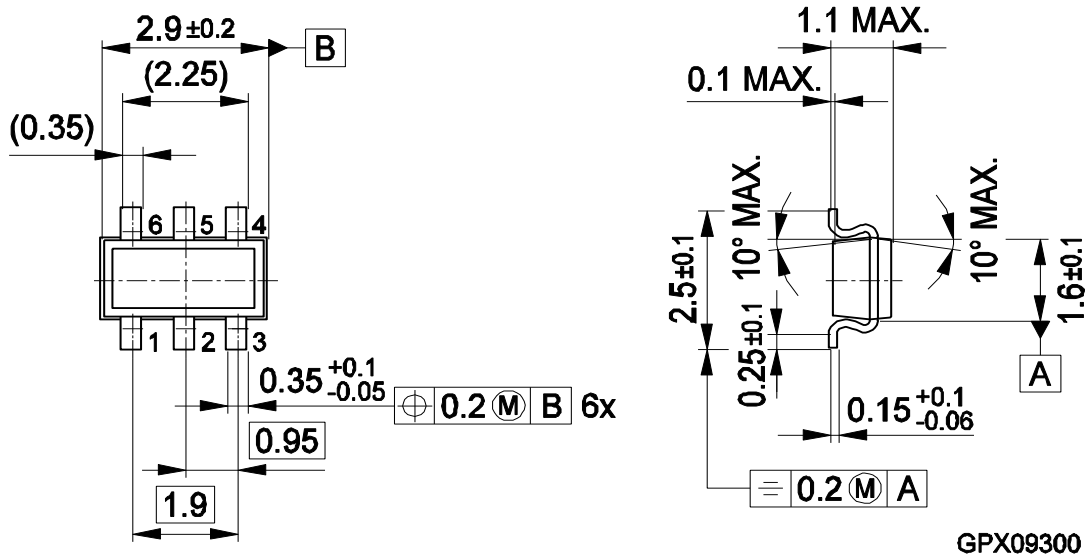
16 Gate charge waveforms



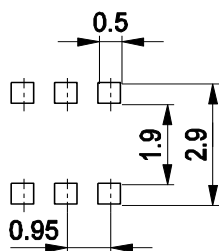


TSOP6

Package Outline:



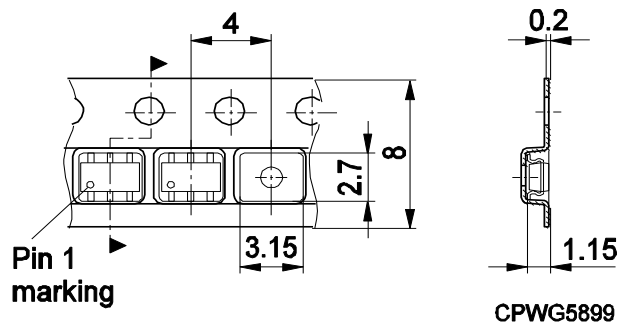
Footprint:



Remark: Wave soldering possible dep.
on customers process conditions

HLG09283

Packaging:



Dimensions in mm



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